

# MOSPEC

## MEDIUM-POWER HIGH VOLTAGE PNP POWER TRANSISTORS

Designed for high-speed switching and linear amplifier application for high-voltage operational amplifier, switching regulators, converters, inverters, deflection stages and high fidelity amplifiers.

### FEATURES:

- \* Collector-Emitter Sustaining Voltage -  
 $V_{CEO(SUS)} = 225\text{-}350V @ I_C = 200mA$
- \* Usable DC Current Gain to 2.0A

**PNP**  
**2N6211**  
**2N6212**  
**2N6213**

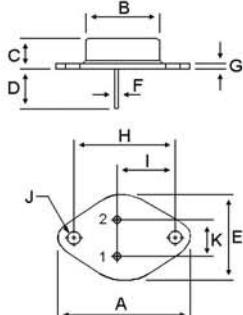
**2 AMPERES**  
**POWER TRANSISTOR**  
**PNP SILICON**  
**225-350 VOLTS**  
**35 WATTS**

### MAXIMUM RATINGS

Rating	Symbol	2N6211	2N6212	2N6213	Unit
Collector-Base Voltage	$V_{CBO}$	275	350	400	V
Collector-Emitter Voltage	$V_{CEO}$	225	300	350	V
Emitter-Base Voltage	$V_{EBO}$	6.0			V
Collector Current-Continuous Peak	$I_C$ $I_{CM}$	2.0 5.0			A
Base Current	$I_B$	1.0			A
Total Device Dissipation @ $T_C = 25^\circ C$ Derate above $25^\circ C$	$P_D$	35 0.2			Watts $W/^\circ C$
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-65 to +200			°C



TO-66

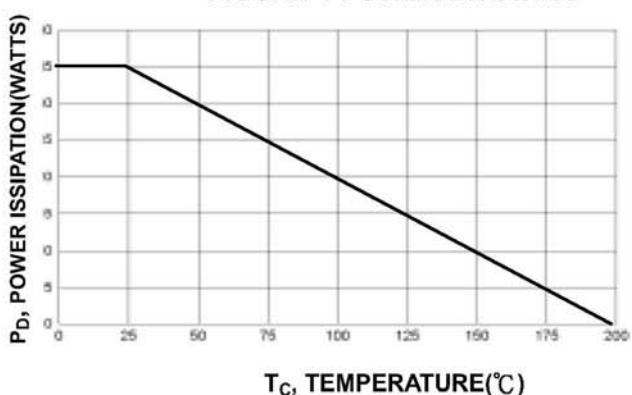


PIN 1.BASE  
2.EMITTER  
COLLECTOR(CASE)

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance to Case	$R_{JC}$	5.0	°C/W

FIGURE-1 POWER DETATING



DIM	MILLIMETERS	
	MIN	MAX
A	30.60	32.52
B	13.85	14.16
C	6.54	7.22
D	9.50	10.50
E	17.26	18.46
F	0.76	0.92
G	1.38	1.65
H	24.16	24.78
I	13.84	15.60
J	3.32	3.92
K	4.86	5.34

ELECTRICAL CHARACTERISTICS (  $T_c = 25^\circ\text{C}$  unless otherwise noted )

Characteristic		Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Collector-Emitter Sustaining Voltage(1) ( $I_c = 200\text{mA}, I_B = 0$ )	2N6211 2N6212 2N6213	$V_{CEO(\text{sus})}$	225 300 350		V
Collector-Emitter Sustaining Voltage ( $I_c = 200\text{mA}, I_B = 0, R_{BE} = 50\ \Omega$ )	2N6211 2N6212 2N6213	$V_{CER(\text{sus})}$	250 325 375		V
Emitter-Base Breakdown Voltage ( $I_E = 0.5\text{mA}, I_C = 0$ ) ( $I_E = 1.0\text{mA}, I_C = 0$ )	2N6212 2N6213 2N6211	$V_{EBO}$	6.0 6.0		V
Collector Cutoff Current ( $V_{CE} = 250\text{V}, V_{BE(\text{off})} = 1.5\text{V}$ ) ( $V_{CE} = 315\text{V}, V_{BE(\text{off})} = 1.5\text{V}$ ) ( $V_{CE} = 360\text{V}, V_{BE(\text{off})} = 1.5\text{V}$ )	2N6211 2N6212 2N6213	$I_{CEV}$		0.5 0.5 0.5	mA
Collector Cutoff Current ( $V_{CE} = 150\text{V}, I_B = 0$ )	All Types	$I_{CEO}$		5.0	mA
Emitter Cutoff Current ( $V_{BE} = 6.0\text{V}, I_C = 0$ )	2N6211 2N6212 2N6213	$I_{EBO}$		1.0 0.5 0.5	mA

## ON CHARACTERISTICS ( 1 )

DC Current Gain ( $V_{CE} = 2.8\text{V}, I_C = 1.0\text{A}$ ) ( $V_{CE} = 3.2\text{V}, I_C = 1.0\text{A}$ ) ( $V_{CE} = 4.0\text{V}, I_C = 1.0\text{A}$ )	2N6211 2N6212 2N6213	$h_{FE}$	10 10 10	100 100 100	
Collector-Emitter Saturation Voltage ( $I_C = 1.0\text{A}, I_B = 125\text{mA}$ )	2N6211 2N6212 2N6213	$V_{CE(\text{sat})}$		1.4 1.6 2.0	V
Base-Emitter Saturation Voltage ( $I_C = 1.0\text{A}, I_B = 125\text{mA}$ )		$V_{BE(\text{sat})}$		1.4	V

## DYNAMIC CHARACTERISTICS

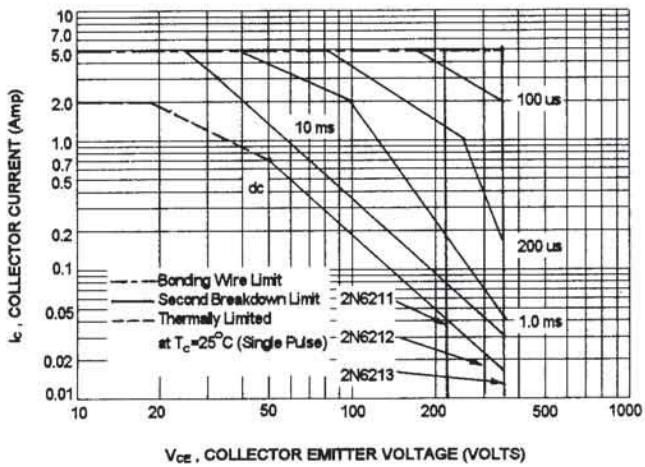
Current Gain-Bandwidth Product (2) ( $I_C = 200\text{mA}, V_{CE} = 10\text{V}, f = 5\text{MHz}$ )		$f_T$	10		MHz
Output Capacitance ( $V_{CB} = 10\text{V}, I_E = 0, f = 1.0\text{MHz}$ )		$C_{ob}$		220	pF

## SWITCHING CHARACTERISTICS

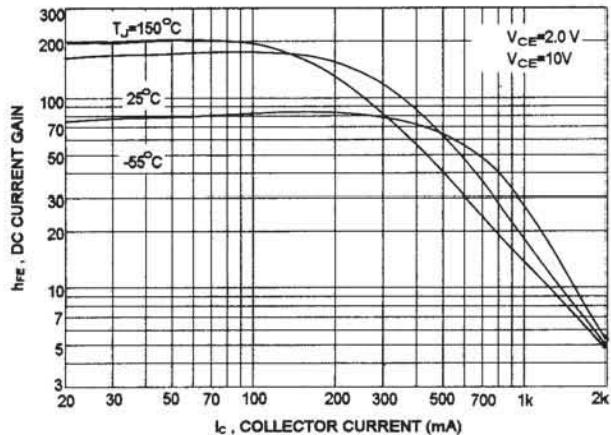
Rise Time	$V_{cc} = 200\text{V}, I_C = 1\text{A}$	$t_r$		0.6	us
Storage Time	$I_{B1} = -I_{B2} = 125\text{mA}$	$t_s$		2.5	us
Fall Time		$t_f$		0.6	us

(1) Pulse Test: Pulse width = 300 us , Duty Cycle  $\leq 2.0\%$ (2)  $f_T = |h_{fe}| \cdot f_{test}$

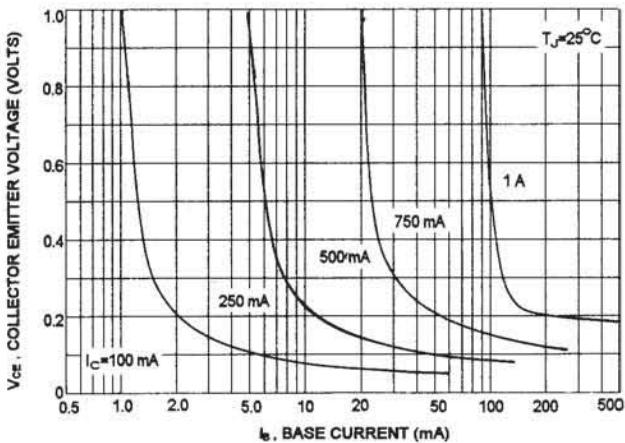
## ACTIVE-REGION SAFE OPERATING AREA (SOA)



## DC CURRENT GAIN



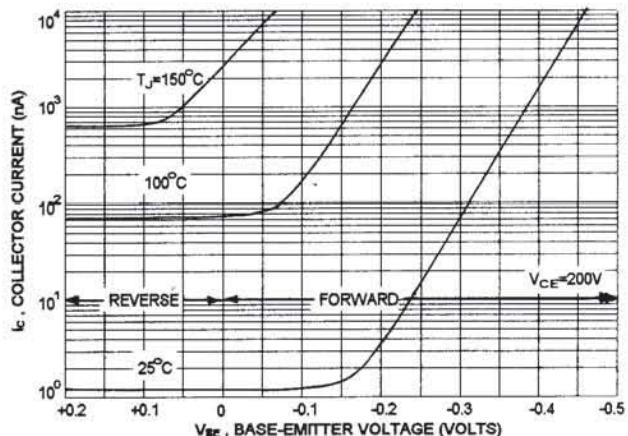
## COLLECTOR SATURATION REGION



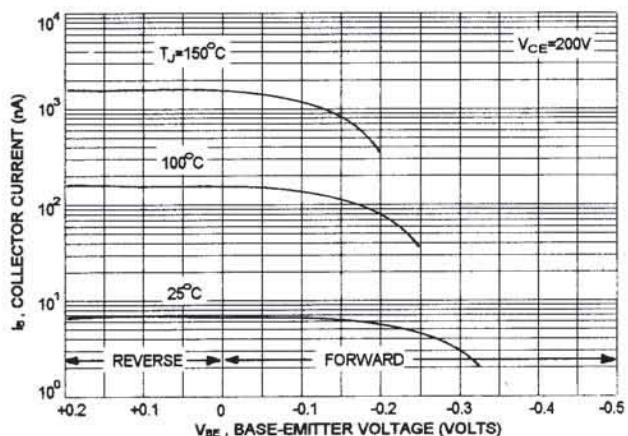
There are two limitation on the power handling ability of a transistor: average junction temperature and second breakdown safe operating area curves indicate  $I_c$ - $V_{ce}$  limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than curves indicate.

The data of SOA curve is base on  $T_{J(PK)}=200^\circ C$ ;  $T_c$  is variable depending on conditions. second breakdown pulse limits are valid for duty cycles to 10% provided  $T_{J(PK)} \leq 200^\circ C$ . At high case temperatures, thermal limitation will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

## COLLECTOR CUT-OFF REGION



## BASE CUT-OFF REGION



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